

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/647,650	TAKAE ET AL.	
Examiner		Art Unit		Page 1 of 1
Duc Nguyen		2643		

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0009996	01-2002	Okada et al.	455/435
*	B	US-5,642,398	06-1997	Tiedemann et al.	455/426.1
*	C	US-2002/0046353	04-2002	Kishimoto, Toyoaki	713/202
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 2000333258 A	11-2000	Japan	TOMOIKE, HIROMOTO	H04Q 07/38
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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